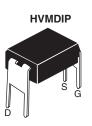
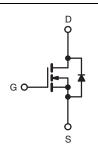


Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	100			
$R_{DS(on)}\left(\Omega\right)$	V _{GS} = 5.0 V 0.27			
Q _g (Max.) (nC)	12			
Q _{gs} (nC)	3.0			
Q _{gd} (nC)	7.1			
Configuration	Single			





N-Channel MOSFET

FEATURES

- · Dynamic dV/dt Rating
- · Repetitive Avalanche Rated
- For Automatic Insertion
- End Stackable
- · Logic-Level Gate Drive
- R_{DS(on)} Specified at V_{GS} = 4 V and 5 V
- 175 °C Operating Temperature
- Compliant to RoHS Directive 2002/95/EC

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The 4 pin DIP package is a low cost machine-insertable case style which can be stacked in multiple combinations on standard 0.1" pin centers. The dual drain serves as a thermal link to the mounting surface for power dissipation levels up to 1 W.

ORDERING INFORMATION				
Package	HVMDIP			
Lead (Pb)-free	IRLD120PbF			
Lead (Fb)-liee	SiHLD120-E3			
SnPb	IRLD120			
On b	SiHLD120			

ABSOLUTE MAXIMUM RATINGS (T _A = 25 °C, unless otherwise noted)						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	100	V	
Gate-Source Voltage			V_{GS}	± 10	\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	
Continuous Drain Current	V _{GS} at 5.0 V	T _A = 25 °C	I _D	1.3		
	V _{GS} at 5.0 V	T _A = 100 °C		0.94	Α	
Pulsed Drain Current ^a			I_{DM}	10		
Linear Derating Factor				0.0083	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	690	mJ	
Avalanche Current ^a			I _{AR}	1.3	Α	
Repetitive Avalanche Energy ^a			E _{AR}	0.13	mJ	
Maximum Power Dissipation T _A = 25 °C		P_{D}	1.3	W		
Peak Diode Recovery dV/dt ^c			dV/dt	5.5	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 175	°C	
Soldering Recommendations (Peak Temperature)	for 10 s			300 ^d	7	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. V_{DD} = 25 V, starting T_J = 25 °C, L = 153 mH, R_g = 25 Ω , I_{AS} = 2.6 A (see fig. 12). c. I_{SD} ≤ 9.2 A, dI/dt ≤ 110 A/ μ s, V_{DD} ≤ V_{DS} , V_{DS} = 175 °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRLD120, SiHLD120

Vishay Siliconix



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R_{thJA}	=	120	°C/W	

PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT	
Static				1			
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	100	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I _D = 1 mA	-	0.12	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	· V _{GS} , I _D = 250 μA	1.0	-	2.0	٧
Gate-Source Leakage	I _{GSS}	,	V _{GS} = ± 10 V	-	-	± 100	nA
7 0	I _{DSS}	V _{DS} =	V _{DS} = 100 V, V _{GS} = 0 V		-	25	μΑ
Zero Gate Voltage Drain Current		V _{DS} = 80 V,	V _{DS} = 80 V, V _{GS} = 0 V, T _J = 150 °C		-	250	
Dunin Course On Chata Basistana	R _{DS(on)}	V _{GS} = 5.0 V	I _D = 0.78 A ^b	-	-	0.27	Ω
Drain-Source On-State Resistance		V _{GS} = 4.0 V	I _D = 0.65 A ^b	-	-	0.38	
Forward Transconductance	9 _{fs}	V _{DS} =	50 V, I _D = 0.78 A ^b	1.9	-	-	S
Dynamic							
Input Capacitance	C _{iss}		$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$ f = 1.0 MHz, see fig. 5		490	-	pF
Output Capacitance	C _{oss}	1			150	-	
Reverse Transfer Capacitance	C _{rss}	f = 1.			30	-	
Total Gate Charge	Qg			-	-	12	nC
Gate-Source Charge	Q _{gs}	V _{GS} = 5.0 V	$I_D = 9.2 \text{ A}, V_{DS} = 80 \text{ V},$ see fig. 6 and 13 ^b	-	-	3.0	
Gate-Drain Charge	Q_{gd}		see lig. 0 and 10		-	7.1	
Turn-On Delay Time	t _{d(on)}	V_{DD} = 50 V, I_D = 9.2 A, R_g = 9.0 Ω , R_D = 5.2 Ω , see fig. 10 ^b		-	9.8	-	- ns
Rise Time	t _r			-	64	-	
Turn-Off Delay Time	t _{d(off)}			-	21	-	
Fall Time	t _f			-	27	-	
Internal Drain Inductance	L _D	1	Between lead, 6 mm (0.25") from		4.0	-	-11
Internal Source Inductance	L _S	package and center of die contact		-	6.0	-	nH
Drain-Source Body Diode Characteristic	s			l			<u>I</u>
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	1.3	_
Pulsed Diode Forward Current ^a	I _{SM}			-	-	10	A
Body Diode Voltage	V _{SD}	T _J = 25 °C, I _S = 1.3 A, V _{GS} = 0 V ^b		-	-	2.5	V
Body Diode Reverse Recovery Time	t _{rr}	T 05.00 :	0.0.4 11/11 400.4 / 5	-	130	140	ns
Body Diode Reverse Recovery Charge	Q _{rr}	$T_J = 25 ^{\circ}\text{C}$, $I_F = 9.2 \text{A}$, $dI/dt = 100 \text{A}/\mu \text{s}^b$		-	0.83	1.0	μС
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L _D)					L _D)

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 μ s; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

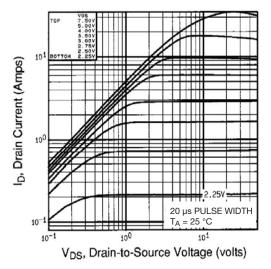


Fig. 1 - Typical Output Characteristics, T_A = 25 °C

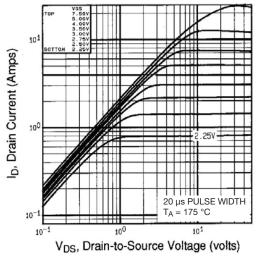


Fig. 2 - Typical Output Characteristics, T_A = 175 °C

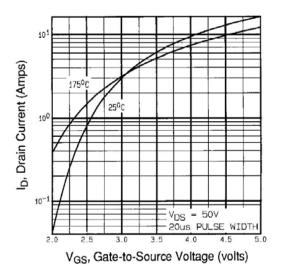


Fig. 3 - Typical Transfer Characteristics

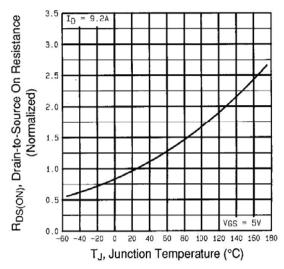


Fig. 4 - Normalized On-Resistance vs. Temperature



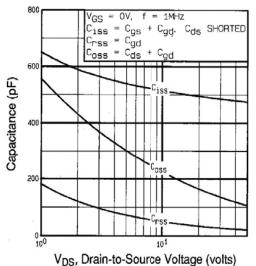


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

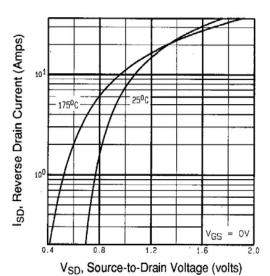


Fig. 7 - Typical Source-Drain Diode Forward Voltage

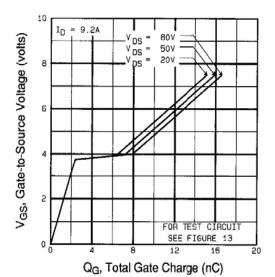


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

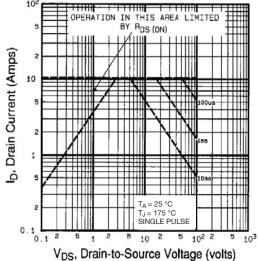


Fig. 8 - Maximum Safe Operating Area





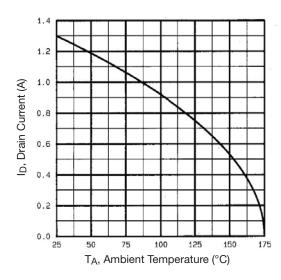


Fig. 9 - Maximum Drain Current vs. Ambient Temperature

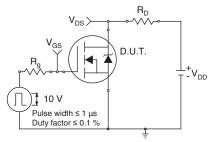


Fig. 10a - Switching Time Test Circuit

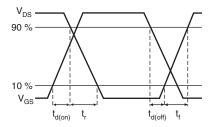


Fig. 10b - Switching Time Waveforms

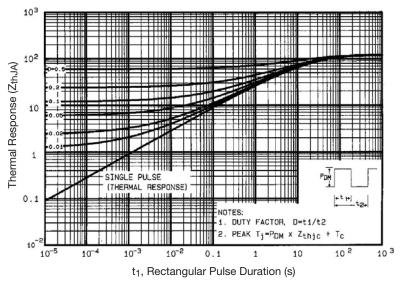


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Ambient



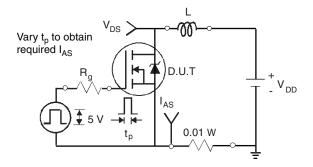


Fig. 12a - Unclamped Inductive Test Circuit

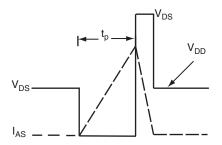


Fig. 12b - Unclamped Inductive Waveforms

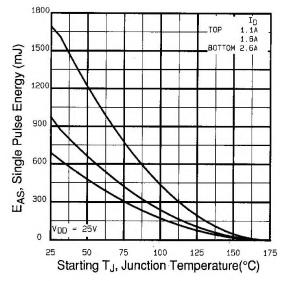


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

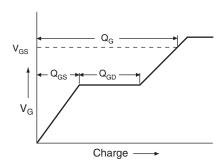


Fig. 13a - Basic Gate Charge Waveform

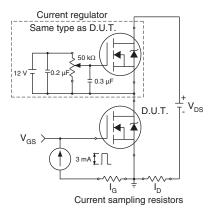
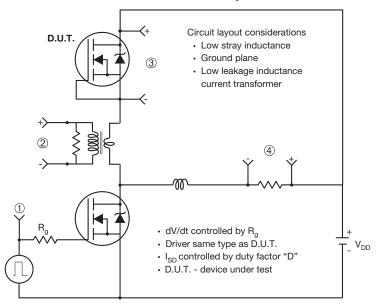


Fig. 13b - Gate Charge Test Circuit





Peak Diode Recovery dV/dt Test Circuit



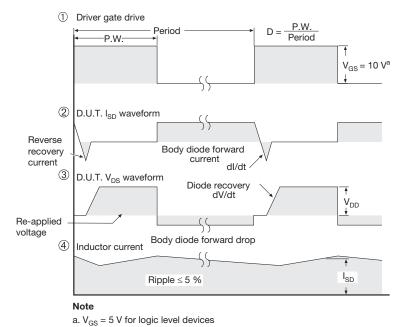
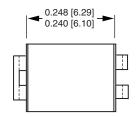
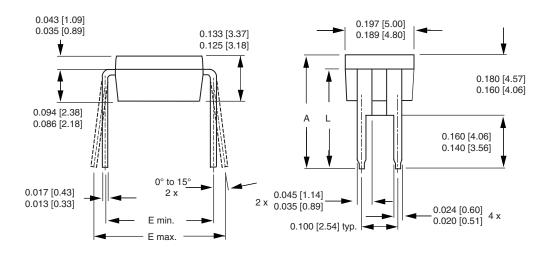


Fig. 14 - For N-Channel

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HVM DIP (High voltage)





	INCHES		MILLIMETERS	
DIM.	MIN.	MAX.	MIN.	MAX.
A	0.310	0.330	7.87	8.38
Е	0.300	0.425	7.62	10.79
L	0.270	0.290	6.86	7.36

ECN: X10-0386-Rev. B, 06-Sep-10

DWG: 5974

Note

1. Package length does not include mold flash, protrusions or gate burrs. Package width does not include interlead flash or protrusions.

Document Number: 91361 Revision: 06-Sep-10



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